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UTILITY PATENT APPLICATION TRANSMITTAL

(for Noncontinuing, Nonprovisional  
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Attorney Docket No. 68671

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under 37 C.F.R. §1.53 (b) is the  
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patent application for:

Title: **X-RAY DIFFRACTION APPARATUS AND  
METHOD**

First Named Inventor or  
Application Identifier: Michael Brauss

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- ( ) An executed Oath or Declaration and Power of Attorney naming the actual inventors is enclosed.
- (X) The names of persons believed to be the actual inventors are set forth in the enclosed unexecuted Oath or Declaration and Power of Attorney (§1.41(a) and §1.53(b)).
- ( ) An Assignment(s) of the invention to \_\_\_\_\_, and cover sheet are enclosed.
- ( ) A check in the amount of \$\_\_\_\_\_ to cover the fee for recording the assignment(s) is enclosed.
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- ( ) A Form PTO-1449 is enclosed.
- ( ) \_\_\_\_\_ References (copies) listed on the Form PTO-1449 are enclosed.
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(X) Priority of application number 60 /127,219 filed on March 31, 1999 in United States is claimed under 35 U.S.C. §119.

- ( ) A certified copy of the priority document is enclosed.
  - ( ) A MicroFiche Computer Program (Appendix) is enclosed.
  - ( ) A Nucleotide and/or Amino Acid Sequence Submission is enclosed.
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## X-RAY DIFFRACTION APPARATUS AND METHOD

### Field of the Invention

The invention relates to an apparatus and method for measuring strength related characteristics of a part 5 using x-ray diffraction techniques and, more particularly, to an apparatus and method for measuring the strength related characteristics at a variety positions on the part.

### Background of the Invention

The use of x-ray diffraction techniques for 10 measuring residual stresses in crystalline substances such as metal or ceramic materials is well-known. The general idea with the use of x-ray diffraction is to subject the material to the radiation of x-rays with the resulting sensed x-ray diffraction peak interpreted to arrive at a 15 measurement of a strength related characteristic, i.e. stress, retained austenite, hardness of the part material, to show, for instance, the level of fatigue in the material. While using coupons or removing the part from service for measurement by x-ray diffraction laboratory 20 equipment is done, neither is particularly satisfactory in that coupons require a portion of the part to be removed therefrom, and removing a part to be measured from service can create undue downtime along with the requisite labor for removal and replacement of the part back into service.

25 Accordingly, there is a need for portable x-ray diffraction equipment that can be used in the field at the site at which a part is located and without requiring the part to be removed from service. Portable x-ray diffraction equipment is known, however, some of these 30 units suffer from great bulk making them less than ideal for use in field conditions. A further shortcoming with known x-ray diffraction equipment lies in the limitations

in moving the goniometer head so that measurements can be taken across a sufficient number of positions on the part to obtain meaningful information therefrom, particularly where the part being tested has been used in the field

5 where corrosion and other environmental use conditions can cause highly localized variations in the strength characteristic being determined. When the only measurements taken are those including such localized aberrations, the determination of what the remaining useful

10 life of the part is before it needs to be retired to avoid fatigue failure thereof can be compromised.

In the laboratory setting this shortcoming requires periodic operator intervention to shift the part being measured so that the goniometer head is in position

15 to direct x-rays at different positions thereon. As is apparent, such operator intervention is time consuming and labor intensive. In the field with current portable units, an operator generally has to physically shift the x-ray diffraction unit including the goniometer head along the

20 part to the different positions at which measurements are desired. In either instance, there is significant operator intervention that is required which is undesirable. In addition, a portable x-ray diffraction unit is needed that can take measurements from complexly-shaped parts and

25 preferably without having to remove them from service while also providing an easy to interpret readout of the results of the measurements to show variations in the fatigue of the part in the region thereof that is measured.

In this regard, currently there is no means

30 available to directly and quantitatively measure the total strain and hence be able to calculate the total stress non-destructively, the dead load strain and hence the dead load stress on the following: wire rope and/or single strand and/or multi-strand cables once they are installed on a

structure or component. In addition there is no technique which can determine the strains on individual strands which may comprise a cable bundle or wire rope.

It would be desirable to be able to measure the  
5 total strain and hence determine the total stress on these types of load bearing members. Total strain is the residual strain plus the restraint strain plus the applied strain. Accordingly, the total strain relates to a material's remaining capacity to bear a load which is  
10 information that is particularly useful for load bearing structures for a number of safety and economic reasons.

Similarly, it would be desirable to be able to measure the dead load strain and hence dead load stress, which is the strain as a result of the weight and restraint  
15 stain of the structure or component without the strain due to the intended carrying load.

Another problem is that currently there is no means available to directly, accurately and non-destructively track the changes in wire rope and cable  
20 strain due to corrosion, creep, fatigue, overload etc.

A further problem is that currently there is no means available to directly and quantitatively and non-destructively measure the strain and hence be able to calculate the stress on the following: wire rope and or  
25 single strand and or multi-strand cables installed on an existing structure or component.

Despite the widespread use of cables, there are few tools available to inspect and characterize the stresses on cables. In fact, at this time there are two  
30 techniques currently in common use, a direct measurement by "jacking", literally by deflecting the cable with a calibrated jack and an indirect method using the "time to damping" of an induced vibration. Both of these approaches to stress measurement are at best an approximation of cable  
35 force due to underlying assumptions as discussed in F.A. Zahn and B. Bitterli's paper "Developments in Non-

Destructive Stay Cable Inspection Methods" delivered at the IABSE Symposium in San Francisco in August, 1995 (see pp. 861-866). This is because the accuracy of the measurement is less than ideal, the total stress in the cable is 5 ignored and the techniques cannot characterize individual strands which may comprise a cable bundle. Accordingly, there is a need for an apparatus and method that can address these shortcomings.

Summary of the Invention

10       In accordance with the present invention, an x-ray diffraction apparatus and method are provided in which an x-ray or goniometer head can be adjusted in different directions to allow the head to direct x-rays at a part from various positions. In this manner, measurements can 15 be taken from a wider region of the part without requiring that the part itself be moved or that an operator move the unit, which can be relatively heavy. In one aspect, the head can be rotated about its internal axis so that it can more readily direct x-rays along curved surfaces of parts 20 while keeping a substantially constant distance therefrom. It is preferred that the apparatus be a portable unit including adjustment mounts to allow the x-ray head to be moved in the different directions so that it can be transported for use in the field at the site at which a 25 part is located. In this instance, the unit allows for measurements to be taken from the part while it remains in service. Accordingly, the present portable unit allows for x-ray diffraction techniques to be used on parts where it is not practical or economic to remove them from service, 30 such as cables or wire ropes used as tension members for bridges. Moreover, the preferred portable x-ray diffraction unit herein provides an easy to interpret readout of the results of its measurements by generating a

map at the part site so that, for example, any abnormalities in stress measurements taken will be highlighted in comparison to adjacent points on the map where more normal measurements are shown.

5        In one form of the invention, an apparatus is provided having an x-ray head adjustable in at least three mutually transverse axes for directing x-rays from different positions toward a part. The apparatus includes a frame for supporting the x-ray head. An x-axis  
10 adjustment mount of the frame is provided and which is operably connected to the head for adjusting the head in an x-axis fore and aft direction. A y-axis adjustment mount of the frame is provided and which is operably connected to the head for adjusting the head in a y-axis lateral  
15 direction. A z-axis adjustment mount of the frame is provided and which is operably connected to the head for adjusting the head in a z-axis vertical direction. Accordingly, the present x-ray diffraction apparatus is significantly improved in terms of its ability to  
20 coordinate movements of the head in three different axes of movement so that it can scan across a region of a part and direct x-rays thereat from different positions for taking measurements at a larger range of positions on the part than had been available via prior x-ray diffraction  
25 equipment. As the adjustment mounts are preferably integrated with the frame that supports the x-ray head, there is little need for operator intervention to move the part to reach the different points thereon from which measurements are desired to be taken.

30        In one form, the frame includes a fixture portion that is adapted to removably attach the frame to the part to allow the x-ray head to be used on parts in the field. With the fixture portion attached to the part to be measured, an operator merely has to initialize the x-ray

diffraction unit for taking the desired measurements and otherwise need not intervene during the operation of the unit. This is in contrast to prior art x-ray diffraction equipment which requires an operator to hold the unit in 5 position with respect to the part while the measurements are taken.

In another form, the fixture portion includes adjustable clamps for removably attaching the frame to different sizes of cables with the adjustable clamps 10 comprising the y-axis adjustment mount to allow the head to be located at different positions along the length of the cable. The adjustable clamps for the fixture portion are advantageous as they do not require a different fixture to be constructed for each different part that is to be 15 measured. Instead, the adjustable clamps can be used on cables of a variety of sizes for attaching the frame thereto.

In one form, the x, y and z adjustment mounts include linear drives for linearly adjusting the head in 20 three mutually perpendicular directions with the x and y adjustment mounts allowing the head to direct x-rays to a predetermined region on the part and the z adjustment mount allowing the focal distance of the head from the part to be adjusted.

25 In another form, the frame and x, y and z adjustment mounts are integrated in a portable x-ray diffraction unit for being transported to different part sites. A stand distinct from the portable unit is provided for supporting the unit a desired part site. The 30 integrated portable x-ray diffraction unit herein allows for measurements to be taken from parts in the field and from different points on the part by way of the integrated adjustment mounts.

It is preferred that the unit and the stand have an adjustable attachment therebetween to allow the unit and stand to be shifted to different positions relative to each other.

- 5 In a preferred form, the head includes detectors for sensing the x-rays off from the part. A controller is provided connected to the head for receiving signals from the detectors and including circuitry adapted to generate maps of a strength related characteristic of the part at  
10 the part site with the strength related characteristic being based on the received signals.

In another form, the head includes an elongate housing having a longitudinal axis, and the frame includes an r-axis adjustment mount operably connected to the head  
15 for adjusting the head in an r-axis rotary direction about the housing axis to allow the head to direct x-rays at contoured parts. Preferably, the frame includes a phi-axis adjustment mount operably connected to the head for adjusting the head in a phi-axis rotary direction  
20 transverse to the r-axis rotary direction. The phi-axis adjustment mount can be disposed forwardly in the x-axis direction from the z-axis adjustment mount.

In a preferred form, a touch sensor is provided which is shifted into engagement with the part with the  
25 head a predetermined distance from the part in the z-axis direction. A controller is signaled by the touch sensor for repeatable locating of the head at the predetermined distance from the part after use of the sensor. Preferably, the controller includes a teach mode to allow  
30 and operator to shift the touch sensor into engagement with the part at various locations thereon by shifting of the head via the adjustment mounts for mapping part contour so that the head precisely directs x-rays toward the part at the various locations along its contour.

In another form of the invention, an apparatus is provided for directing x-rays at parts with curved surfaces. The apparatus includes an x-ray head having an elongate housing including a longitudinal axis thereof, and

5 a frame for supporting the x-ray head. An adjustment mount of the frame allows the head to undergo rotary movement about the longitudinal axis thereof to substantially keep the head at a predetermined distance from a curved surface of a part at which x-rays are directed at various positions

10 along the part curved surface. Prior x-ray diffraction equipment has been limited to taking measurements from flat, planar surfaces. Where the part includes a curved surface, an operator would have to physically shift or rotate the part to allow the x-ray head to direct x-rays at

15 different positions therealong. In contrast, the present apparatus including the adjustment mount for rotating the head about the housing axis allows the head to take measurements at various positions along the part curved surface while maintaining a substantially constant distance

20 therefrom.

Preferably, a plurality of other adjustment mounts are provided for moving the head in a plurality of different directions so that the head moves in a path that substantially matches the contour along the part defined by

25 the different positions at which x-rays are to be directed. As described more fully hereinafter, the contour of the part can be mapped into the memory of the controller which can then coordinate the operation of the adjustment mounts to allow the head to move in a path that keeps it at

30 constant distance from the part despite complex shapes of its contour that may be present.

In another aspect of the invention, a method for obtaining strength related characteristics of a part is provided. The method includes providing a portable x-ray

diffraction unit including an x-ray head having integrated adjustment mechanisms for shifting the head in a plurality of different directions, transporting the portable unit to a site at which the part is in service, orienting the x-ray  
5 head relative to the part for directing x-rays thereat, shifting the x-ray head via the adjustment mechanisms to direct x-rays at various positions on the part for obtaining a sufficiently large distribution range of measurements of the desired part characteristics for proper  
10 strength analysis thereof, detecting the diffraction of the x-rays from the part at the various positions thereon, transmitting signals to a controller for the portable unit that are based on the detected x-rays, interpreting the signals in circuitry of the controller to render  
15 measurements of at least one strength related characteristic of the part, and generating a map at the part site of the part characteristics across the entire distribution range of measurements for the part.

By generating maps at the part site, a person can  
20 readily determine the areas of the measured region where the strength related characteristic is in either normal or abnormal ranges therefor. The present method using an x-ray head having integrated adjustment mechanisms and which is incorporated in a portable x-ray diffraction unit makes  
25 it possible to generate the maps on site at a part location.

**Brief Description of the Drawings**

FIG. 1 is a perspective view of a portable x-ray diffraction apparatus including a frame having adjustable  
30 mounts for allowing an x-ray head to move in different directions and a fixture portion for attaching the frame of the unit to a bridge tension member to be measured;

FIG. 2 is a side-elevational view of a portable unit similar to Fig. 1 including integrated x, y, z, r and phi adjustment mounts for moving the x-ray head in respective x, y, z, r and phi axes corresponding to the 5 different mounts;

FIG. 3 is a view similar to Fig. 2 showing a goniometer and detector mount of the x-ray head rotated 90 degrees from the Fig. 2 position;

FIG. 4 is a plan view of the portable unit of 10 Figs. 2 and 3 showing the x-ray head rotated about the phi axis;

FIG. 5 is a front elevational view of the portable unit of Figs. 2-4 showing an arcuate oscillation drive for the x-ray head;

15 FIG. 6 is a side elevational view of another portable x-ray diffraction unit including adjustment mounts on a frame thereof for moving the x-ray head in different directions and showing a stand portion of the frame for supporting the unit at the part site;

20 FIG. 7 is a front elevational view of the portable unit of Fig. 6 showing coarse y and z axes adjustment mounts of the stand for moving the head in corresponding y and z axes of movement;

25 FIG. 8 is a side elevational view of another portable unit including a stand for supporting the unit a part site with adjustment mounts for moving the head in different directions;

30 FIG. 9 is a rear elevational view of the unit and stand portion of Fig. 8 showing y and z axes adjustment mounts for moving the head in corresponding y and z axes of movement;

FIG. 10 is a flow chart of a method of providing for automatic refocusing of the head at a predetermined focus distance from the part to be measured;

FIGS. 11A and 11B are a flow chart of a method in accordance with the present invention of teaching a controller for the x-ray diffraction unit the path in which the head is to travel to obtain the desired measurements 5 from different positions on a part to be measured;

FIG. 12 is an elevational view of the part sensor for use in the autofocus and teach map methods of the present invention; and

FIGS. 13A-13C are views of maps of residual 10 stress of a part that can be generated in the field with the apparatus and method of the present invention.

**Detailed Description of the Preferred Embodiments**

In FIG. 1, an x-ray defraction apparatus 10 in accordance with the present invention is shown. The 15 apparatus 10 includes an x-ray head 12 from which x-rays are directed at a part 14, such as the illustrated bridge tension member 16. The main advantage provided by the present apparatus 10 is in the ability of the x-ray head 12 to be moved in a plurality of different directions relative 20 to the part via various adjustment mounts, generally designated 18, that are provided on frame structure 20 supporting the x-ray head 12 for its movements. In this regard, the adjustment mounts 18 afford the head 12 a range of movement so that the head 12 can direct x-rays at the 25 part from different positions thereof and at corresponding different positions on the part 14. As discussed, this is particularly helpful where the part 14 is in service and subject to various use and environmental conditions that can cause highly specific and localized variations in the 30 strength-related characteristic being measured by the x-ray defraction apparatus 10. By having the ability to scan a region of the part, aberrations in the characteristic being

measured by the apparatus 10 can be readily determined so, for instance, such localized variations will not unduly influence the determination as to the remaining useful life of the part 14. By way of example and not limitation, the 5 adjustment mounts 18 herein can provide the x-ray head 12 with movements in the range of 2 to 4 inches.

In the preferred and illustrated form of FIG. 1, the apparatus 10 is a portable unit that can be transported to a site at which the part 14 is in service. As shown, 10 the portable apparatus 10 includes a fixture portion 22 at the front thereof which enables the frame 20 to be removably attached to the bridge cable or wire rope 16. In this manner, the portable x-ray apparatus 10 can be taken to the bridge and mounted to the cable 16 so that 15 measurements can be taken therefrom without requiring it be removed from service or that the operator hold the apparatus 10 while the measurements are taken. In addition, the apparatus 10 allows measurements to be taken in conditions where due to loading or environmental 20 reasons, the bridge tension member 16 is moving or vibrating. The fixture portion 22 is designed such that it does not introduce or attenuate the axial strain experienced by the wire rope or cable.

The fixture portion 22 allows easy positioning of 25 the apparatus 10 relative to the bridge tension member 16 and is suitable for a wide range of wire rope and cable bundle sizes. To this end, the fixture portion 22 includes a pair of adjustable clamps 24. The adjustable clamps 24 of the fixture portion 22 allow the apparatus 10 to be used 30 on tension members 16 having a wide variety of sizes without requiring a different fixture each time the tension member that is to be measured changes in diameter or configuration over a previously measured member 16. The adjustable clamps 24 each include a right angle bracket

member 26 having an upper plate portion 28 and a vertical rear plate portion 30. Arms 32 and 34 of the frame 20 are attached at the forward ends as by welding or the like to the rear plate 30 of the clamps 24. Tightening members in 5 the form of chains 36 are provided to adjustably tighten the clamps 24 onto the bridge tension member 16. The chains 36 run over an upstanding guide 38 near the juncture of the bracket plates 28 and 30 and around the tension member 16, as can best seen in FIG. 2. To tighten the 10 clamps 24 onto the tension member 16, free ends 38 of the chains 36 are pulled to draw the chains 36 tight about the tension member 16 and bracket 26. A plastic protective sheet 39 can be wrapped on the tension member 16 to minimize damage thereto with the clamps 24 tightened 15 thereon. Releasing the adjustable clamps 24 allows the portable apparatus 10 to be clamped onto various locations along the length of the tension member 16 and about its circumference, and can serve as one of the adjustment mounts 18 for coarse movement of the goniometer head 12 in 20 a lateral, y-axis direction, as will be more fully described hereinafter.

The x-ray defraction apparatus 10 will next be more particularly described. The x-ray head 12 herein utilizes divergent x-ray optics that are preferably 25 combined with a close proximity focus distance of approximately 30 to 40 millimeters, a predetermined sized aperture of the head 12 which results in an appropriately shaped divergent x-ray beam such as to illuminate the bridge tension member 16 as shown at 40 in FIG. 1, and a 30 movable mask 42 which can limit the strain data measured, for example, to one wire rope or cable strand at a time. The mask 42 is specifically designed for the wire rope or cable 16 to be measured so that the curvature thereof has

little or no effect on the measurements being taken via the x-ray head 12 herein.

The divergent x-ray optics provide better illumination of the material grains resulting in better definition of the defraction peaks through increased counting statistics. The close proximity also reduces the attenuation of the x-ray signal both traveling to and from the object 14 being measured. In the case of textured materials and/or materials which exhibit preferred orientation of the material grains, better illumination is helpful and typically wire rope and cable strands 16 would be subjected to textured conditions by virtue of their fabrication process. Accordingly, the preferred short focal distance herein is particularly useful where the part 14 being measured is the illustrated bridge tension member 16.

In typical x-ray defraction systems, the x-ray head 12 generates x-rays in an elongate housing 44 extending in a fore and aft x-axis direction along an internal, longitudinal axis 46 thereof. A target anode (not shown) in the housing 44 directs x-rays out from the housing 44 through a collimator 48 at the lower, forward end thereof. The x-rays from the collimator 48 are directed at a specific point on the part 14 to be measured. Fiber optic detectors 50 are mounted on either side of the collimator 48 on an arcuate detector mount 52. Depending on the x-ray defraction technique utilized, the x-ray head 12 can remain stationary while directing x-rays at the point on the part 14 from which measurements are desired, or the head can be oscillated in an arcuate path through a variety of tilt angles via a beta oscillation drive 54 (FIG. 5) so that the point on the part 14 is subject to multiple exposures by way of the multiple tilt angles at which the x-rays are directed at the part 14 from the head

12, and specifically the collimator 48 thereof. As is known, the beta oscillation drive 54 can be of a rack and pinion variety, including an arcuate rack 56 that is driven in a similarly shaped slot of an arcuate slide bearing 5 block 58.

The beta oscillation drive 54 typically is not designed for the x-ray head 12 to take measurements from different points on the part 14 absent movement of the part 14 itself or without manually holding and moving the head 10 along the part 14 to the different positions. In this regard, the apparatus 10 of the present invention utilizes a plurality of adjustment mounts 18 that provide for either manual or automated movement of the x-ray head in a plurality of different directions without requiring that 15 the part 14 be moved or that the operator hold the x-ray defraction apparatus at the different positions. The adjustment mounts 18 can include those that allow for both rough adjustments of the x-ray head 12 where high speed of movement and/or a large range of motion are desired, and 20 for small, precision movements of the x-ray head 12 so that x-rays can be directed at different positions on the part 14 that are in close proximity to each other.

The frame 20 including the fixture portion 22 thereof in the apparatus 10 of FIG. 1 includes the 25 following adjustment mounts 18: x-axis adjustment mount 60 for highly controlled movements of the x-ray head 12 in the fore and aft x-axis direction as indicated by arrow 62; rough x-axis adjustment mount 64 which allows for coarse movements of the x-ray head 12 in the x-axis direction 62; 30 rough z-axis adjustment mount 66 which allows for coarse up and down movement of the x-ray head 12 in a pivotal z-axis direction indicated by arrow 68.

In a lateral y-axis direction such as along the bridge tension member axis 70, the previously described

fixture adjustable clamps 24 can be utilized for coarse movements by releasing the clamps 24 and shifting the apparatus 10 along the axis 70. Alternatively, the rough x-axis adjustment mount 64 can be used as will be described 5 hereinafter for coarser, larger movements of the x-ray head 12 in the axial direction of the member 16.

As can be seen in FIG. 1, the x-ray head 12 can be connected to the forward end of the bearing block 58 which, in turn, is connected to a bracket portion 72 of the 10 frame structure 20. A clevis member 74 is connected to the rear of the bracket portion 72. A threaded adjustment rod 76 extends in the x-axis direction 62 into an x-axis slide 78 with the threaded rod 76 being rotatably mounted therein. The slide member 78 can have a dovetail shape for 15 fitting in dovetail slot 80 of slide bearing block 82. An internally threaded nut (not shown) fixed relative to the rod 76, and the slide member 78 and block 82 can be provided so that rotating the enlarged knob end 84 of the adjustment rod 76 causes the member 78 to linearly slide in 20 the x-axis direction 62 in the slot 80. The slide member 78 is operably connected to the x-ray head 12 at the forward end of the frame 20 by a pair of ears 86 upstanding therefrom and adjustably connected to the clevis member 74, as described more fully hereinafter.

25 For coarse movements along the x-axis direction 62, the rough x-axis adjustment mount 64 employs pivoting of the arms 34 about pivot members 88 attached to the rear of the arms 34. The bottom of the bearing block 82 is in sliding engagement with the tops of the arms 34 so that as 30 the arms 34 are pivoted about their respective pivot members 88 in a direction away from each other, the bearing block 82 will be caused to slide forwardly along the tops of the arms 34, thus moving the head 12 in the x-axis direction 62. Bringing the arms 34 back toward their

parallel disposition causes the bearing block 82 to slide rearwardly in the x-axis direction 62. To use the mount 64 to move the head 12 in the y-axis direction, both arms 34 are pivoted in the same direction while recognizing that 5 this will also give the head 12 a component of movement in the x-axis direction due to the pivoting action of the arms 34 which will be imparted to the head 12. In addition, axial strains experienced by the bridge tension member 16 can be taken up by slight pivoting of the arms 34 which, 10 although creating movement of the head 12, should be of a sufficiently minimal character so as not to cause errors during measurement.

As previously described, the ears 86 extend upwardly from the slide member 78. In this regard, a 15 support member 90 is provided between the slide member 78 and the ears 86 with the ears 86 projecting upwardly therefrom. The ears 86 are spaced laterally from each other so that they fit between rearwardly extending arms 92 of the clevis member 74. The arms 92 and ears 86 are 20 secured by way of quick disconnect pins 94 extending through aligned apertures 96 and 98 thereof.

The rough z-axis adjustment mount 66 is formed by arcuate slots 100 provided in each of the clevis arms 92 and through which adjustment screws 102 extend and into the 25 ears 86. Accordingly, to make coarse adjustments in the z-axis direction 68, the quick disconnect pins 94 are pulled and the adjustment screws 102 are loosened. This allows the position of the x-ray head 12 to be adjusted in the z-axis direction 68 by pivoting thereof in a substantially vertical direction until at the desired vertical 30 distance from the part 14 from which measurements are to be taken. Once in the proper position, the adjustment screws 102 can be tightened in their adjusted positions in the slots 100 with the pins 94 reinserted in the apertures 96

and 98. As is apparent, because of the pivoting action, there is a fore and aft x-axis component of movement associated with the coarse vertical movement in the z-axis direction 68.

5       The apparatus 10 of FIG. 1 also includes a rough phi-axis adjustment mount 104 to allow the x-ray head 12 to be pivoted about a vertical axis. As shown in FIG. 1, the phi-axis adjustment mount 104 is formed by a pivot member 106 which allows the support member 90 to be pivoted  
10 relative to the slide member 78 in a rotary phi-axis direction as indicated by arrow 108. In this manner, the x-ray head 12 can be provided with compound x-y axes movement via the phi-axis adjustment mount 104.

FIGS. 2-5 are directed to an apparatus 10a similar to apparatus 10 in that the x-ray head 12 thereof is capable of movements in a plurality of different directions. It also is preferably adapted to be portable and mounted to a bridge tension member 16 via fixture portion 22 thereof. As best seen in FIG. 4, the rough x-axis adjustment mount 64 is substantially the same as previously described. Similarly, the rough z-axis adjustment mount 66 is also similar to that previously described for apparatus 10. The x-axis adjustment mount 60 of apparatus 10 is substantially the same in apparatus 10a; however, an additional fine x-axis adjustment mount 110 is incorporated in frame 112 of the apparatus 10a so that both coarse and precision measurements of the head 12 can be made in the x-axis direction 62. Also, a fine phi-axis adjustment mount 114 is incorporated in the frame 112.

30       As can be seen in FIGS. 2 and 3, the frame 112 includes a vertical wall portion 116 and a horizontal wall portion 118 connected at the top of the wall portion 118 and projecting forwardly therefrom. The horizontal wall portion 118 generally extends above and overhangs the x-ray

head 12 with the x-ray head 12 cantilevered out from the bottom of the vertical wall portion 116 by a rearwardly extending support arm 120 connected to the rear of the x-ray head housing 44 at its forward end and to mounting portion 122 at the rear thereof with the mounting portion 122 being offset from the housing axis 46.

The apparatus 10a further includes a fine z-axis adjustment mount 124 incorporated in the frame 110a for moving the x-ray head 12 in a vertical z-axis direction as indicated by arrow 125. This is in addition to the previously described rough z-axis adjustment mount 66 which allows for coarser pivoting movement of the x-ray head 12 in an up and down fashion along an arcuate path as indicated by arrow 68. Z-axis drive block 126 is attached to the frame 112 near the bottom of the vertical wall portion 116 and a gusset 128 is attached between the wall portions 116 and 118 at the juncture thereof. A z-axis linear drive in the form of screw drive 130 is mounted in the z-axis drive block 126 with its upper end in the gusset portion 128. Where the z-axis drive 130 is automated, motor 132 therefor can be located in the gusset portion 128 and include an encoder 133 for providing precise position feedback information to a controller 135 (FIG. 13) which can be disposed in a control box (not shown) remote from the apparatus 10a to provide a closed-loop feedback system for automated movements of the x-ray head 12 herein. Accordingly, operation of the screw drive 130 causes the x-ray head 12, which is operably connected to the z-axis drive block 126, to shift in a vertical up and down direction 125 for providing small, precision movements of the head 12. In this manner, the precision movements provided to the head 12 by the z-axis drive 130 allows for precision tuning of the focal distance of the head 12 from the piece part 14 to be measured.

The frame 112 also incorporates a fine y-axis adjustment mount 134. More particularly, the drive block 126 includes a dovetail slot 136, and a y-axis slide member 138 has a rear dovetail portion 140 which mates in the 5 dovetail slot 136. The fine y-axis adjustment mount 134 is operably connected to the x-ray head 12 by way of cantilevered portion 142 extending forwardly from the y-axis slide member 138 and attached to the bottom of the mounting portion 122 of support arm 120. A y-axis linear 10 drive in the form of screw drive 144 is provided, as can be seen in FIG. 4. Where the y-axis drive 144 is automated, y-axis motor 145 is provided including an encoder 147 similar to the z-axis motor 132. Accordingly, operation of the screw drive 144, either manually or automatically if it 15 is motorized, causes the head 12 to move in a lateral, y-axis direction 146. For the phi-axis adjustment mount 114, the horizontal wall 118 includes a lower wall portion 148 that is pivotal relative to upper wall or handle portion 150. In this regard, operation of the y-axis screw 20 drive 144 causes the head 44 to shift laterally relative to the wall portion 148 thereabove, as can be seen in FIG. 4.

The fine phi-axis adjustment mount 114 is provided at the forward end of the wall portion 118 and includes a pivot drive member 152 pivotally interconnecting 25 the lower and upper wall portions 148 and 150. Where automated, the phi-axis adjustment mount 114 includes motor 154 and associated encoder 156. Accordingly, operation of the phi-axis pivot drive member 152 causes pivoting of the wall portion 148 relative to the wall portion 150 about 30 rotary phi-axis indicated by arrow 158. This is in addition to the rotary movement provided by phi-axis adjustment mount 104 in rotary direction 108 about a pivot axis that is rearwardly of the pivot axis of the rotary direction 158.

The fine x-axis adjustment mount 110 includes slide member 158 and slide bearing 160 which can have a dovetail mating fit with one another, as can be seen in FIG. 5. The slide member 158 can be provided on the gusset 5 128 with the bearing 160 formed in the lower wall portion 148. A linear x-axis drive in the form of screw drive 162 is provided in the slide 158, and where automated, includes a motor 132 and associated encoder 133. Operation of the x-axis screw drive 162 causes fine precision movements of 10 the x-ray head 12 in the fore and aft, x-axis direction indicated by arrow 164 this movement is in addition to the coarse x-axis movement afforded by rough x-axis adjustment mount 64.

An r-axis adjustment mount 166 is also provided 15 at the rear of the vertical wall portion 116 for rotating the x-ray head 12 about its axis 46. The r-axis adjustment mount 166 is operably connected to the head 12 via the structure between the frame wall portion 116 and the head housing 44 so that rotation of the housing 44 also entails 20 rotation of the fine x-axis adjustment mount 110, fine phi-axis adjustment mount 114, fine z-axis adjustment mount 124, and fine y-axis adjustment mount 134. The r-axis adjustment mount 166 includes a rotary drive in the form of rotary member 168, and where automated, a motor 170 and 25 associated encoder 172 for rotating the member 168 in a rotary r-axis direction as indicated by arrow 174.

The r-axis adjustment mount 166 is of particular value where curved surfaces exist on the part 14 such as pipes and the like so that rotation of the head 12 in the 30 r-axis direction 174 keeps the head 12 at a substantially constant distance from the curved surface. In this manner, the r-axis mount adjustment 166 saves the time associated with the process of lifting the head 12 away from the part, rotating the curved surface and then bringing the head 12

back into the proper focused position relative to the part curved surface, and the potential for errors this process entails. Instead, the r-axis adjustment mount 166 allows the head 12 to be rotated about its axis 46 to track the 5 curvature of the curved surface on the part 14 maintaining a substantially constant focused distance therefrom without requiring constant recalibration each time a different point on the part is to be measured.

In both apparatus 10 and apparatus 10a, the 10 adjustment mounts 18 provide the head 12 the ability to be moved to different positions relative to the part 14 without moving the part itself. Both rough and fine adjustments mounts 18 are provided so that an operator can move to different regions on a part 14 in a rapid manner 15 where accuracy is not as critical but speed of movement is more important, and then can use the fine adjustment mounts to precisely control head movement as it scans across a particular region on the part 14 between measurement points thereon. This combination provides for highly efficient 20 and accurate measurements across a representative sampling of points on a part 14 so that determinations can be more accurately made with respect to the measured strength characteristic(s) of the part 14 and its remaining useful life. In addition to the advantage with respect to curved 25 surfaces previously discussed, the movements of the head 12 in the x-, y- and z-axes allow for parts having multilevel surfaces to be measured without requiring operator intervention to move the parts 14, and the attendant time delays associated therewith, as described above. 30 Accordingly, the present invention provides improved flexibility in terms of the types of parts 14 that can be efficiently measured and accurately characterized with the x-ray defraction equipment described herein.

Referring next to FIGS. 6 and 7, x-ray diffraction apparatus 10b is shown which is similar to those previously described although it lack the fixture portion 22 and instead is adapted more generally for 5 measuring different types of parts, such as pipes. To this end, the apparatus 10b includes a forward measuring portion 176 including the x-ray head 12 and a rearward stand portion 178 that are distinct from each other and are interconnected via an adjustable connection 180 similar to 10 the previously described rough z-axis adjustment mount 66 in both apparatus 10 and 10a. In this manner, the relative position between the measuring portion 176 and the stand portion 178 can be adjusted in a pivotal direction as indicated by arrow 182. The measuring portion 176 of the 15 apparatus 10b incorporates substantially the same fine x-axis adjustment mount 110, fine phi-axis adjustment mount 114, fine z-axis adjustment mount 124, fine y-axis adjustment mount 134, and r-axis adjustment mount 166 as in the previously described apparatus 10a. Accordingly, the 20 head 12 is capable of taking measurements from a large number of different positions in a region on the part 14 without necessitating movement of the part itself. Further, because of the distinct nature of the portions 176 and 178 of the apparatus 10b, the unit is highly portable 25 and accordingly, both are provided with handles with the handle for the measuring portion 176 formed on upper wall portion 150 as in apparatus 10a, and the stand portion 178 including a handle 184, as best seen in FIG. 6.

Coarse movements of the x-ray head 12 can be 30 provided by adjustment mounts 18 incorporated into the stand portion 178. A rough x-axis adjustment mount 186 includes an x-axis linear drive in the form of screw drive 188 which can be either manually operated or automated via motor 190 and associated encoder 192 thereof. Operation of

the x-axis screw drive 188 will cause the head 12 to shift in the x-axis direction 164. Rough y-axis adjustment mount 194 is similarly constructed including a y-axis linear drive in the form of screw drive 196 which can be either 5 manually operated or automated via motor 198 and associated encoder 200. Accordingly, operation of the screw drive 196 causes movement of the x-ray head 12 in the y-axis direction 146. Finally, rough z-axis adjustment mount 202 is provided on the stand portion 178 and includes a z-axis 10 linear drive in the form of screw drive 204 that can be either manually operated or automated via motor 206 and associated encoder 208. Accordingly, operation of the linear drive 204 causes the x-ray head 12 to undergo coarse and rapid movement in the psi-axis direction 125.

15 As is apparent, each of the rough x-, y- and z-axes adjustment mounts 186, 194 and 202, respectively, shift the entire measuring portion 176 including all of the adjustment mounts thereof in the corresponding direction of movement. In this manner, the relative positions of the 20 fine adjustments mounts will not change as the rough adjustment mounts 186, 194 and 202 are operated. Further, it will be noted that the construction of the rough and fine adjustments 18 are very similar in apparatus 10b. Accordingly, it is contemplated that their main distinction 25 in terms of providing the head 12 with either coarse or fine, precision movements may be with respect to the speed at which they are operated.

It should be recognized that instead of the stand portion 178, a robot arm or the like could be utilized, 30 particularly where the apparatus 10b is not required for field use. The robot arm could be controlled to give coarse movements to the measuring portion 176 to facilitate rapid movement of the head 12 to the general area from which x-rays are to be directed at the part to be measured.

FIGS. 6 and 7 also show a housing 209 connected to the stand portion 178 by bracket arm 211 with the housing 209 including the electronics for interpreting the signals received by the detectors 50. Mounting the housing 209 to the stand 178 as shown is desirable so that its heavy weight is not borne by the adjustment mounts and so that it does not have to be moved by the associated drives thereof.

To mount the apparatus 10b to the part 14 being measured, a pair of magnetic feet 210 can be provided at the lower end thereof. The magnetic feet 210 can include permanent magnets for clamping the stand portion 178 tightly to the magnetic material of the part 14 which is inactivated. In addition, the feet 210 can include a safety strap attachment 212 to provide additional support by a safety strap wrapped about the part 14 and pulled tight thereabout via crank arm 214 of the attachment 212.

FIGS. 8 and 9 are directed to another x-ray diffraction apparatus 10c in accordance with the invention which also includes a forward measurement portion 214 including x-ray head 12 and a rearward stand portion 216 with an adjustable interconnection 218 therebetween similar to apparatus 10b. The adjustable interconnection 218 is slightly different in that both portions 214 and 216 include clevises 220 and 222, respectively, in which respective arcuate slots 224 and 226 are formed. An interconnection link 228 extends between the clevises 220 and 222 and can be fixed at various positions in the slots 224 and 226 at either end thereof. In this manner, the portions 214 and 216 can be pivoted in an arcuate up and down direction as indicated by arrow 228 with a so-called knuckling action provided by the wide range of relative positions they can assume based on the different positions the link 228 can be fixed in each of the slots 224 and 226.

The forward measuring portion 214 is significantly modified over that of x-ray diffraction apparatus 10b as the wall portions 116 and 118 of the frame 112 are absent due to the elimination of the adjustment 5 mounts in the measuring portion 214. In this manner, the x-ray head 12 can more readily fit into confined spaces such as in the inside diameter of a pipe or in other openings of parts 14 including surfaces to be measured. Adjustments of the head 12 can be provided via the rearward 10 stand portion 216 and the adjustment mounts thereof which are substantially the same as that described for apparatus 10b. In this regard, the stand portion 216 includes an x-axis adjustment mount 186, a y-axis adjustment mount 194 and a z-axis adjustment mount 202. In this instance, 15 because of the lack of the fine adjustment mounts in the measuring portion 214, the speed of the associated motors of the respective adjustment mounts incorporated in the stand portion 216 can be reduced so as to improve the accuracy in moving the head 12 between positions to be 20 measured as previously has been discussed. Accordingly, the mounts 186, 194 and 202 serve as both the rough and the fine adjustment mounts for the head 12 in apparatus 10c.

FIGS. 10, 11a and 11b show flow charts that depict methods for creating a map of the shape or 25 configuration of the region or portion of the part 14 desired to be measured so that the head 12 can move under command of the controller 135 via the adjustment mounts 18 to the precise positions needed to have properly focused x-rays directed at the positions on the part to be measured. FIG. 10 shows how focusing can be accomplished using a part sensor in the form of touch sensor 230, shown in FIG. 12. The touch sensor 230 includes a probe 232 that when lowered 30 into engagement with the part is depressed for actuating a microswitch 234 housed in the probe body 236. Circuitry in

the sensor 230 detects the actuation of the switch 234 and signals the controller 135 by way of interconnect cable 238.

To use the touch sensor 230, it is removed from  
5 a stored position remote from the x-ray head 12 and placed onto the head 12 so that the probe 232 extends in a downward direction parallel to the collimator 48. An operator using a remote control box can coordinate movement of the head via the adjustment mounts and once in position  
10 lower the head 12 down until the probe 232 engages the surface of the part 14 to be measured. At this point, the head will be in its focus position at a predetermined distance defined by the length of the probe 232 from the part surface. Accordingly, for different focus distances,  
15 different length probes 232 can be utilized. Once the probe 232 engages the part surface, the controller 135 will receive the signal from switch 234 and store the position of the head 12 in memory, and in particular the positions of each of the adjustment mounts. Thereafter, the head 12  
20 moves back to a home or initial position away from the part 12, and the touch sensor 230 is placed back in its stored position. At this point, all an operator has to do to focus the head 12 relative to the part surface is to click on a refocus icon in a Windows based program for instance  
25 or a "teach" key on the remote control box held by the operator and the head 12 under command of the controller 135 will automatically move back down to the previously determined focus position.

Referring next to FIGS. 11a and 11b, the software  
30 of the controller 135 can be programmed to allow the controller 135 to learn or be taught the contour on the region of the part surface from which measurements are desired. Although it is contemplated that the touch sensor 230 will be utilized for this purpose, it is also possible

that the software can be adapted to accept and understand a digital interpretation of the part configuration, such as via a CAD drawing. To build the part configuration map in accordance with FIGS. 11a and 11b, the numerals 1 and 2 after the letters x, y, z indicate whether the motors are for the fine adjustment mounts (numeral 1) or for the rough adjustment mounts (numeral 2). To build the part map, the operator moves the head 12 by way of control over the adjustment mounts such as either via a PC Windows operating program or by controls on the remote control box. The operator moves the head to a position over each point on the part surface from which x-rays are to be directed thereat. At this position, the operator can actuate the "teach" key and the head will use the above-described "autofocus" routine to focus on the part surface. In a like manner, the operator will move the head 12 to the next position from which x-rays are to be directed at the next point on the part surface and initiate the "autofocus" sequence previously described. In this manner, each position of the head 12 will be stored in the controller so that the controller can command the head 12 to move in a precise path keeping the head 12 at a focused distance from the part positions to be measured. In addition, because of the use of the various adjustment mounts 18 as previously described, the x-ray diffraction equipment described herein can be made to automatically take measurements from fairly complex shapes without requiring any operator intervention.

Further, where the equipment is used at a part site, it is desirable for the controller 135 to be adapted for generating maps of the measured strength characteristic so that an operator in the field can make ready comparisons of, for example, stress measurements to easily determine whether localized stress aberrations are present or more importantly if there undue tensile stresses that are more

representative of overall fatigue affecting part life. As shown in the stress maps of FIGS. 13A-13C, the areas on the maps of FIGS. 13B and 13C between the vertical lines show undesirable tensile stresses in an easy to see fashion. By 5 providing these types of maps to field personnel at their job site, it is anticipated that the value of the x-ray diffraction equipment will be unquestionably realized.

While there have been illustrated and described particular embodiments of the present invention, it will be 10 appreciated that numerous changes and modifications will occur to those skilled in the art, and it is intended in the appended claims to cover all those changes and modifications which fall within the true spirit and scope of the present invention.

**WHAT IS CLAIMED IS:**

1. An apparatus having an x-ray head adjustable in at least three mutually transverse axes for directing x-rays from different positions toward a part, the apparatus comprising:

a frame for supporting the x-ray head;

an x-axis adjustment mount of the frame operably connected to the head for adjusting the head in an x-axis fore and aft direction;

a y-axis adjustment mount of the frame operably connected to the head for adjusting the head in a y-axis lateral direction; and

a z-axis adjustment mount of the frame operably connected to the head for adjusting the head in a z-axis vertical direction.

2. The apparatus of claim 1 wherein the frame includes a fixture portion adapted to removably attach the frame to the part to allow the x-ray head to be used on parts in the field.

3. The apparatus of claim 2 wherein the fixture portion includes adjustable clamps for removably attaching the frame to different sizes of cables with the adjustable clamps comprising the y-axis adjustment mount to allow the head to be located at different positions along the length of the cable.

4. The apparatus of claim 1 wherein the x, y, and z adjustment mounts include linear drives for linearly adjusting the head in three mutually perpendicular directions with the x and y adjustment mounts allowing the head to direct x-rays to a predetermined region on the part

and the z-adjustment mount allowing the focal distance of the head from the part to adjusted.

5. The apparatus of claim 1 wherein the frame and x, y, and z adjustment mounts are integrated in a portable x-ray diffraction unit for being transported to different part sites , and

a stand distinct from the portable unit for supporting the unit at a desired part site.

6. The apparatus of claim 5 wherein the unit and the stand have an adjustable attachment therebetween to allow the unit and stand to be shifted to different positions relative to each other.

7. The apparatus of claim 5 wherein the head includes detectors for sensing the x-rays off from the part, and

a controller connected to the head for receiving signals from the detectors and including circuitry adapted to generate maps of a strength related characteristic of the part at the part site with the strength related characteristic being based on the received signals.

8. The apparatus of claim 1 wherein the head includes an elongate housing having a longitudinal axis, and the frame includes an r-axis adjustment mount operably connected to the head for adjusting the head in an r-axis rotary direction about the housing axis to allow the head to direct x-rays at contoured parts.

9. The apparatus of claim 8 wherein the frame includes a phi-axis adjustment mount operably connected to the head for the adjusting the head in a phi-axis rotary direction transverse to the r-axis rotary direction.

10. The apparatus of claim 9 wherein the phi-axis adjustment mount is disposed forwardly in x-axis direction from the z-axis adjustment mount.

11. The apparatus of claim 1 including a touch sensor which is shifted into engagement with the part with the head a predetermined distance from the part in the z-axis direction, and

a controller signaled by the touch sensor for repeatable locating of the head at the predetermined distance from the part after use of the sensor.

12. The apparatus of claim 11 wherein the controller includes a teach mode to allow an operator to shift the touch sensor into engagement with the part at various locations thereon by shifting of the head via the adjustment mounts for mapping part contour so that the head precisely directs x-rays toward the part at the various locations along its contour.

13. The apparatus of claim 12 wherein the head includes an elongate housing having a longitudinal axis, and the frame includes an r-axis adjustment mount operably connected to the head for adjusting the head in an r-axis rotary direction about the housing axis to allow the head to focus x-rays at parts having contours including curved surfaces without moving the part.

14. An apparatus for directing x-rays at parts with curved surfaces, the apparatus comprising:

an x-ray head having an elongate housing including a longitudinal axis thereof;

a frame for supporting the x-ray head; and

an adjustment mount of the frame which allows the head to undergo rotary movement about the longitudinal axis thereof to substantially keep the head at a predetermined distance from a curved surface of a part at which x-rays are directed at various positions along the part curved surface.

15. The apparatus of claim 14 including a plurality of other adjustment mounts for moving the head in a plurality of different directions to allow the head to move in a path that substantially matches the contour along the part defined by the different positions at which x-rays are to be directed.

16. A method for obtaining measurements of strength related characteristics of a part, the method comprising:

providing a portable x-ray diffraction unit including an x-ray head having integrated adjustment mechanisms for shifting the head in a plurality of different directions;

transporting the portable unit to a site at which the part is in service;

orienting the x-ray head relative to the part for directing x-rays thereat;

shifting the x-ray head via the adjustment mechanisms to direct x-rays at various positions on the part for obtaining a sufficiently large distribution range of measurements of the desired part characteristics for proper strength analysis thereof;

detecting the diffraction of the x-rays from the part at the various positions thereon;

transmitting signals to a controller for the portable unit that are based on the detected x-rays;

interpreting the signals in circuitry of the controller to render measurements of at least one strength related characteristic of the part; and

generating a map at the part site of the part characteristic across the entire distribution range of measurements for the part.

17. The method of claim 16 including sensing when the head is shifted to a focus position a predetermined distance from the part, signaling the controller when the focus position has been reached, storing in memory of the controller the position of the adjustment mechanisms to keep the head at the focus position, and operating the adjustment mechanisms via the stored positions to precisely shift the head to the focus position in a repeatable manner.

18. The method of claim 17 wherein the positions on the part to be measured are on different level surfaces of the part or on curved surfaces of the part, an operator shifts the head to different positions from which it is desired to direct x-rays at the part positions via the adjustment mechanisms, storing the positions of the adjustment mechanisms associated with the different head positions in the controller for mapping a desired path of movement of the head for taking measurements from the different part positions, and causing the head to undergo the desired path of movement to allow measurements to be taken from complexly shaped parts without requiring movement thereof.

19. The method of claim 16 wherein the part includes a curved surface and the adjustment mechanisms include a rotary adjustment mechanism, and the x-ray head is shifted by rotating the head via the rotary adjustment mechanism

about an internal axis of the head to substantially maintain the head at a predetermined distance from the part curved surface for directing x-rays at positions thereon without requiring movement of the part.

20. The method of claim 16 including initializing the position of the head relative to the part, storing the part contour in a memory of the controller, and causing the head to shift from the initialized position by the adjustment mechanisms to keep a substantially constant distance from the part based on the stored part contour.

21. The method of claim 16 wherein the x-ray head is oriented relative to the part by mounting the unit to the part so that the part does not have to be taken out of service to obtain the strength related characteristics thereof.

22. The method of claim 21 wherein the part is a cable for a bridge, the unit is transported to a part site by transporting the unit to the bridge, and the unit is mounted to the part by releasably clamping the unit via a fixture thereof to the bridge cable.

23. The method of claim 16 wherein the part strength related characteristic is stress and the map is generated by creating a map curve line interconnecting the stress measurement for each position across the distribution range of positions measured on the part for graphically showing areas of stress concentration in the distribution range on the map.

24. A method of measuring strains on load bearing members while the members are subject to loads, the method comprising:

providing an x-ray diffraction apparatus;

mounting the apparatus to a load bearing member while it is subject to loading;

adjusting a fixture for the apparatus to the size of the load bearing member to be measured to allow the apparatus to be used with different sizes of load bearing members;

measuring the strains of the load bearing member with the apparatus.

25. The method of claim 24 wherein the load bearing members are wire rope, single strand or multi-strand cables supporting load bearing structures, or individual strands of a cable bundle or wire rope.

26. The method of claim 24 wherein the load bearing members are measured while in situ as tension members for bridge structures.

27. A method for taking x-ray diffraction measurements from parts having multi-level or curved surfaces, the method comprising:

providing a x-ray head that is shiftable in a plurality of different directions;

teaching a controller for the x-ray head the shape of a portion of a part from which measurements are desired; and

shifting the x-ray head under command of the controller in a predetermined path based on the taught shape of the part portion for directing x-rays at different

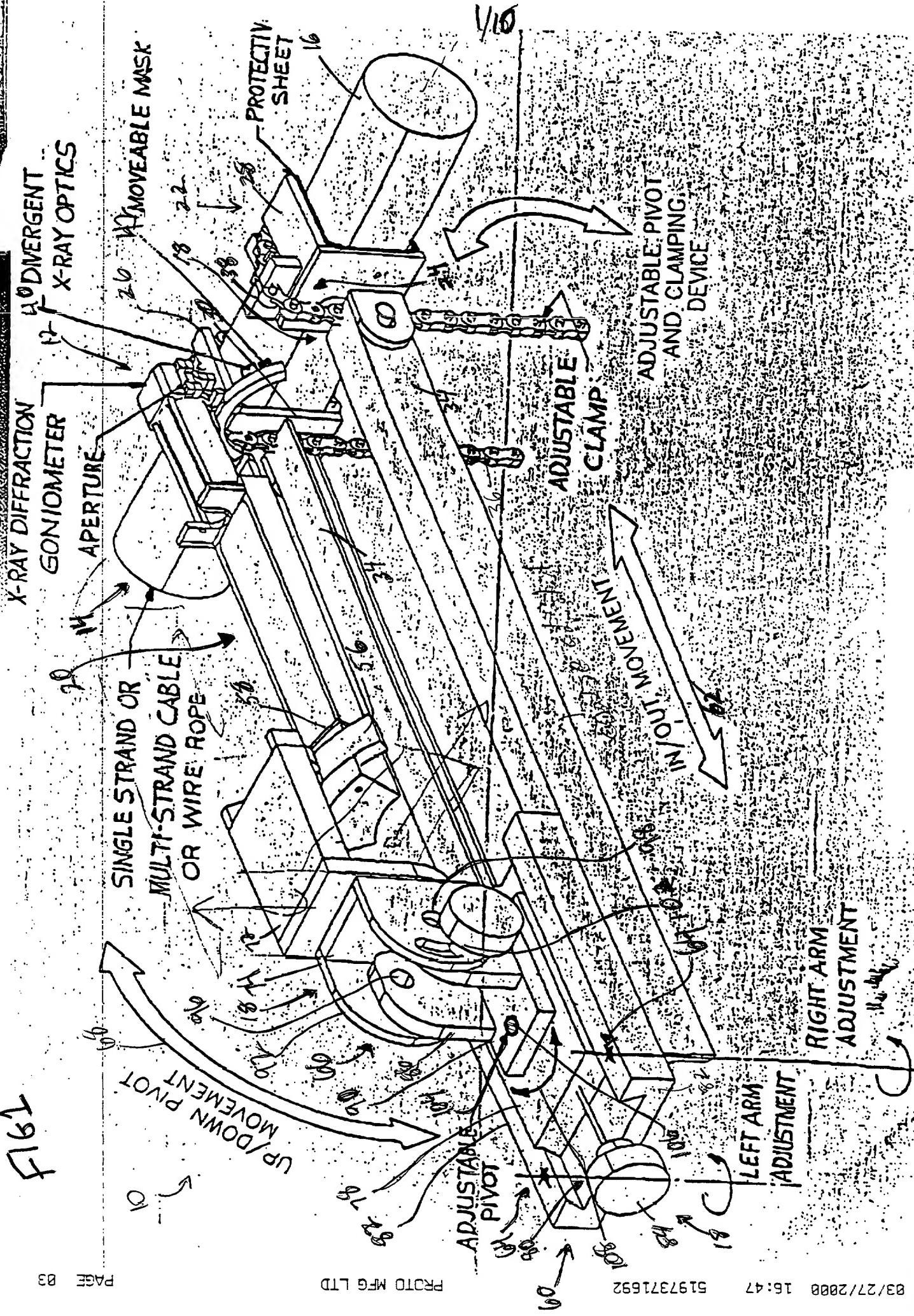
positions therealong while keeping the head at a substantially constant distance therefrom.

28. The method of claim 27 wherein the controller is taught the part portion shape by providing a remote control for use by an operator, operating the remote control to shift the head to the different positions from which x-rays are to be directed at corresponding different positions on the part portion, signaling the controller via the remote control with the different positions of the head, and storing the different positions in memory of the controller to define the predetermined path of travel of the head along the shape of the part portion.

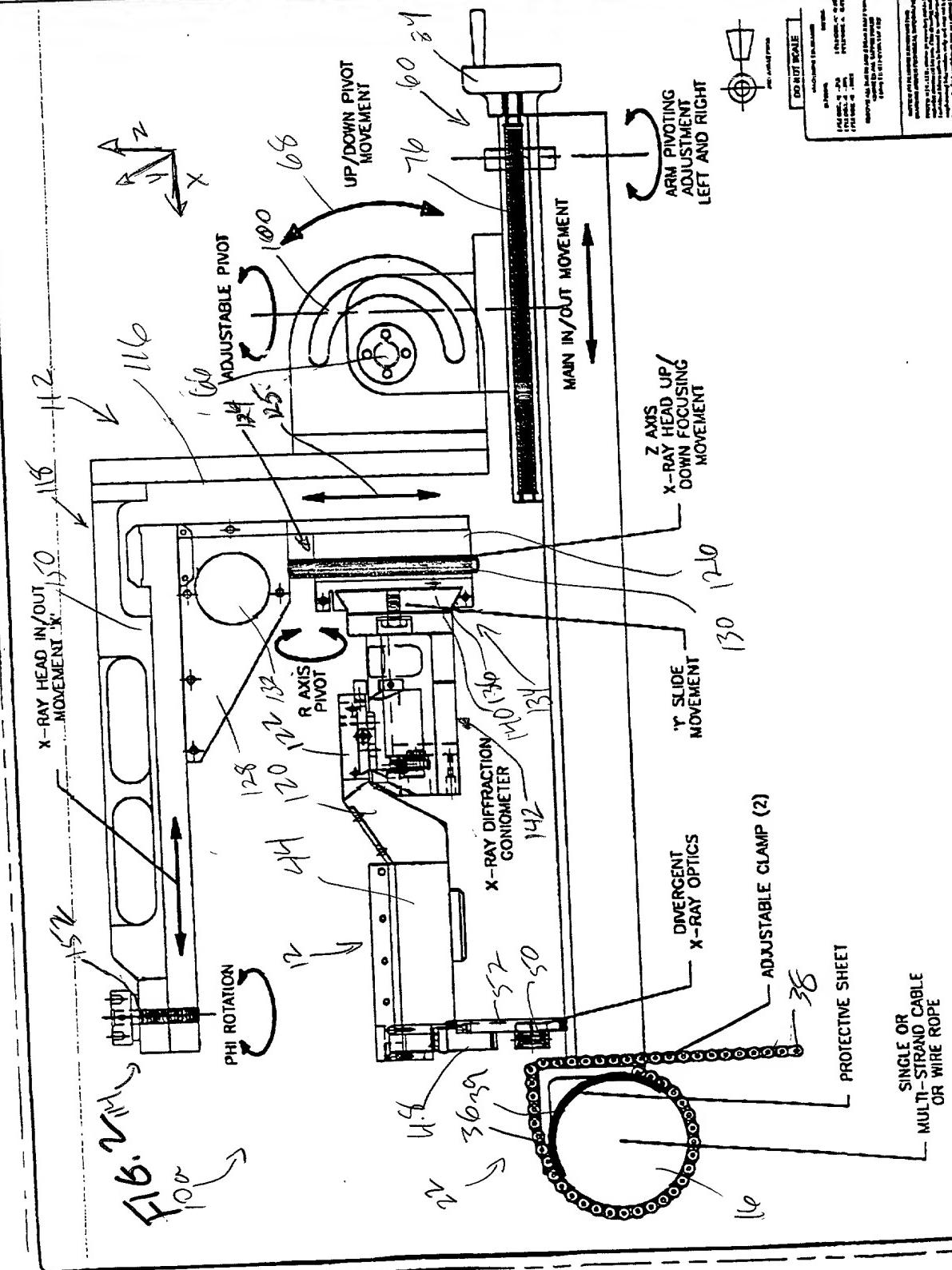
Abstract of the Disclosure

In accordance with the present invention, an x-ray diffraction apparatus and method are provided in which an x-ray or goniometer head can be adjusted in different directions to allow the head to direct x-rays at a part from various positions. In this manner, measurements can be taken from a wider region of the part without requiring that the part itself be moved or that an operator move the unit, which can be relatively heavy. In one aspect, the head can be rotated about its internal axis so that it can more readily direct x-rays along curved surfaces of parts while keeping a substantially constant distance therefrom. It is preferred that the apparatus be a portable unit including adjustment mounts to allow the x-ray head to be moved in the different directions so that it can be transported for use in the field at the site at which a part is located. In this instance, the unit allows for measurements to be taken from the part while it remains in service. Accordingly, the present portable unit allows for x-ray diffraction techniques to be used on parts where it is not practical or economic to remove them from service, such as cables or wire ropes used as tension members for bridges. Moreover, the preferred portable x-ray diffraction unit herein provides an easy to interpret readout of the results of its measurements by generating a map at the part site so that, for example, any abnormalities in stress measurements taken will be highlighted in comparison to adjacent points on the map where more normal measurements are shown.

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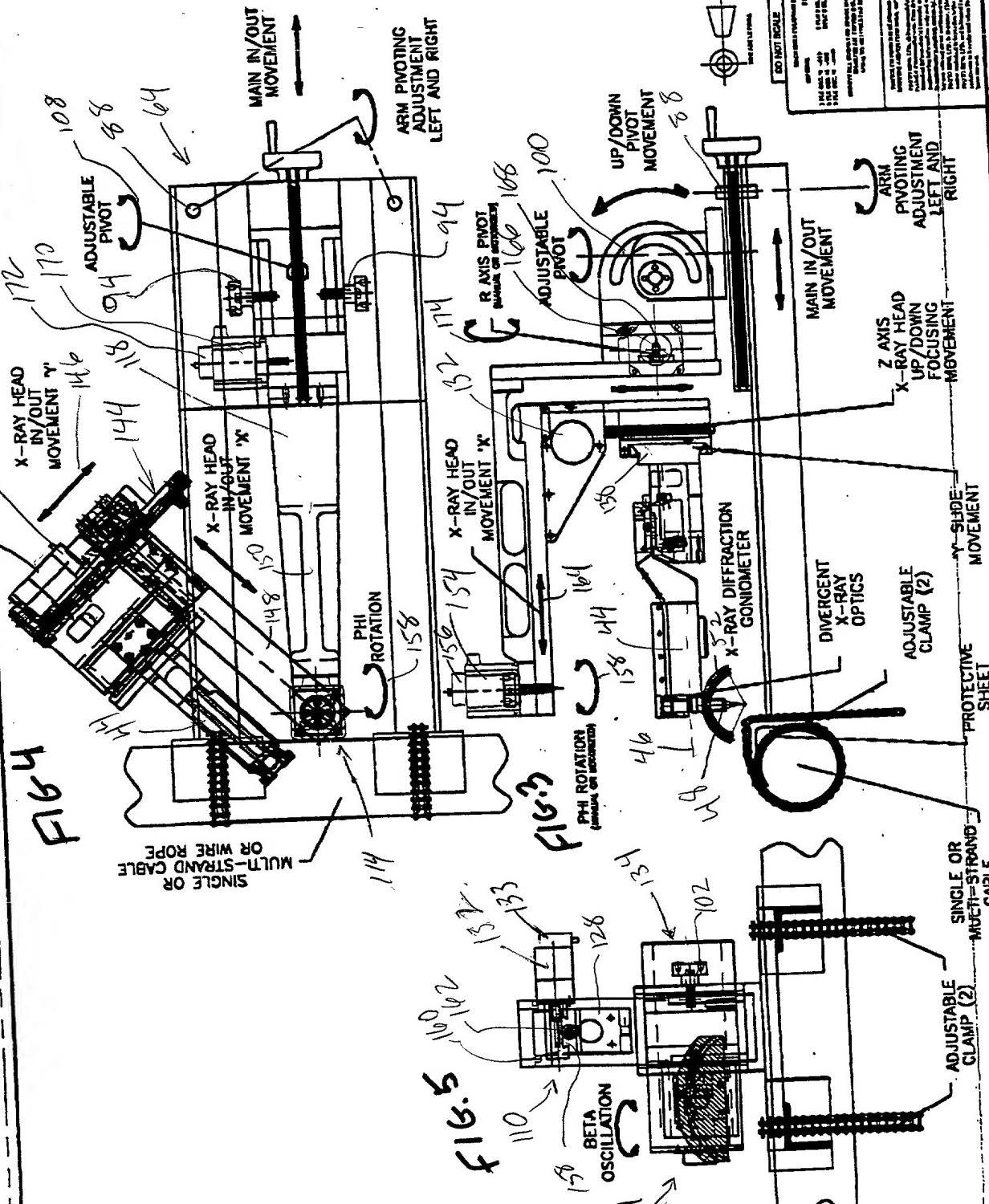


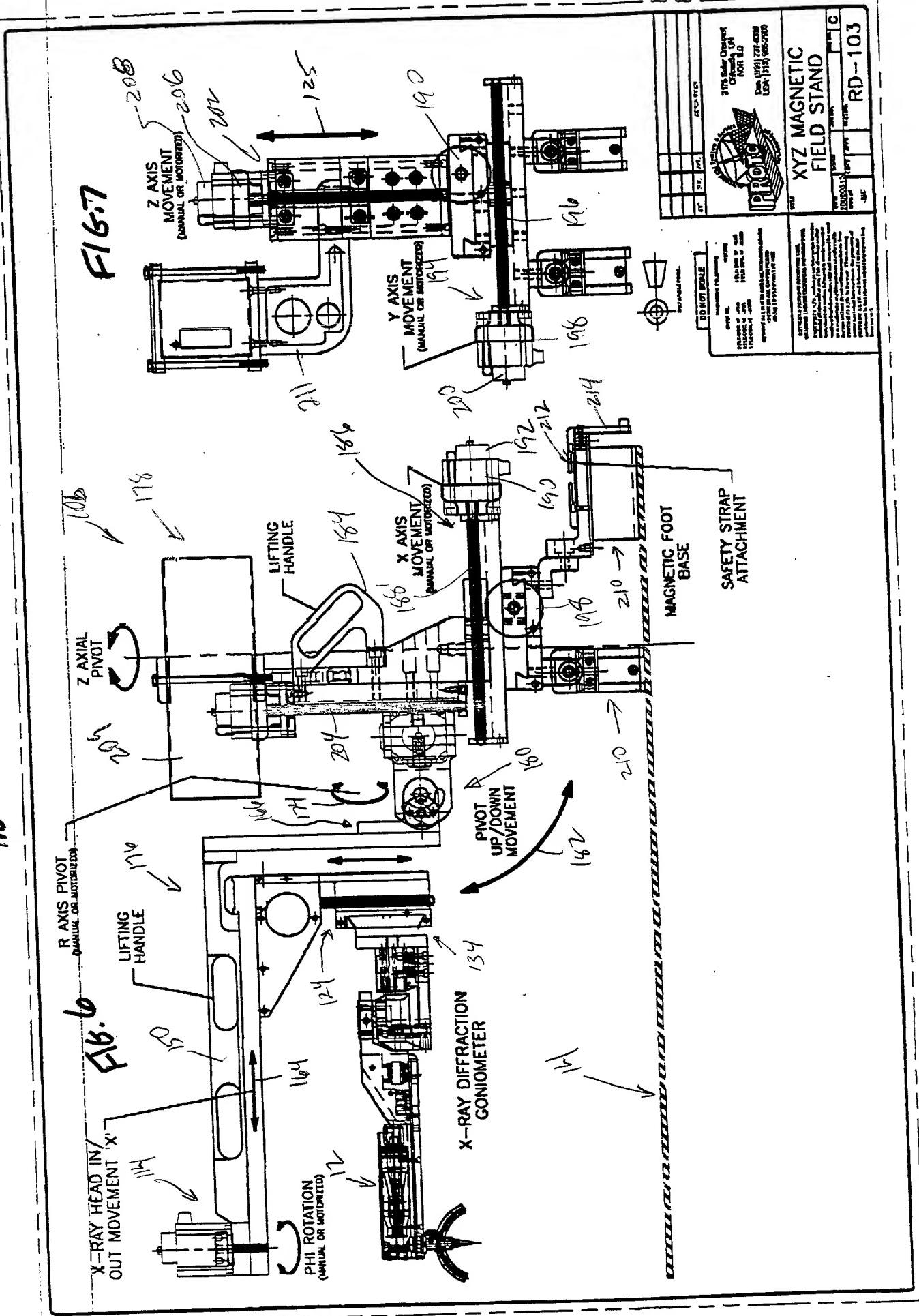
NOTES



2015 Series Drawing	Order No.	RD-103
Rev. 000	Date	08/27/2000
PROTEC		
CABLE STRESS ANALYSIS XRD SYSTEM		
Part No.	Part Name	Spec. Ref.
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104	105	106
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994	995	996
997	998	999
999	1000	1001

NOTES:



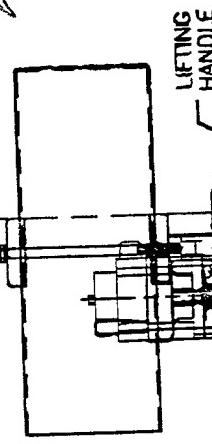


S/0

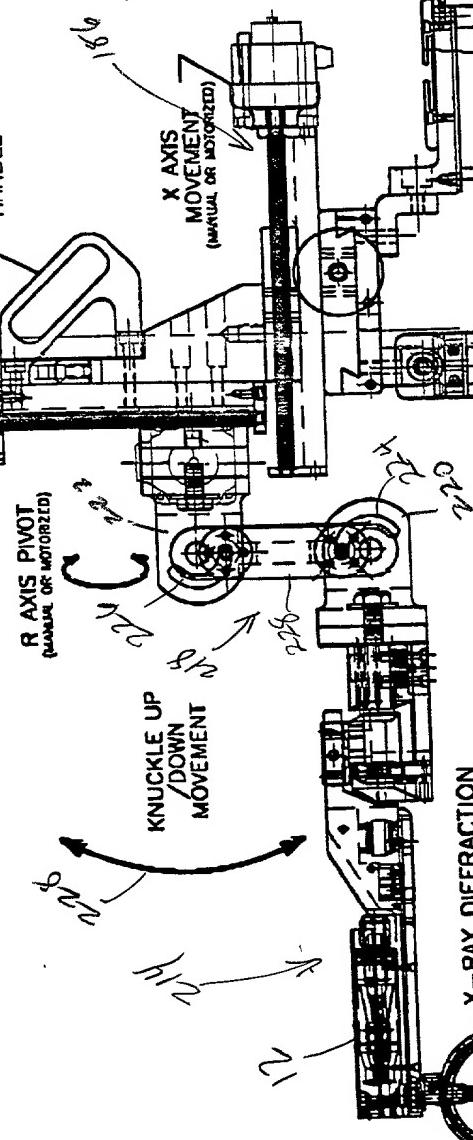
Z AXIAL  
PIVOT

F16.8

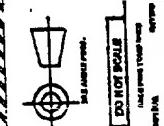
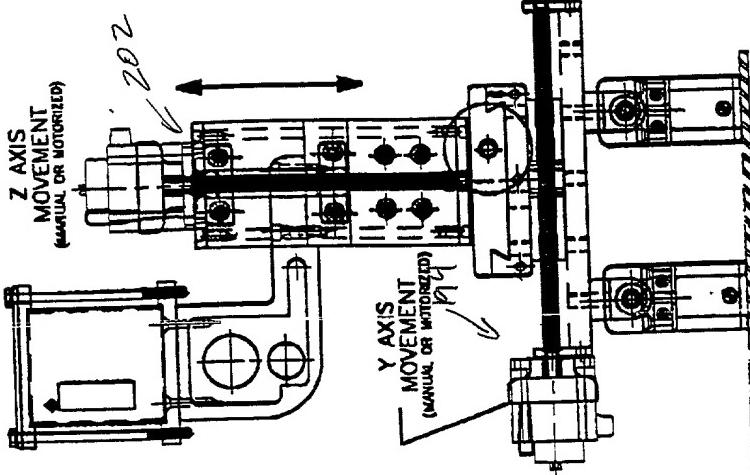
10C  
1/4



R AXIS PIVOT  
(MANUAL OR MOTORIZED)



F16.9



MAGNETIC FOOT  
BASE  
SAFETY STRAP  
ATTACHMENT

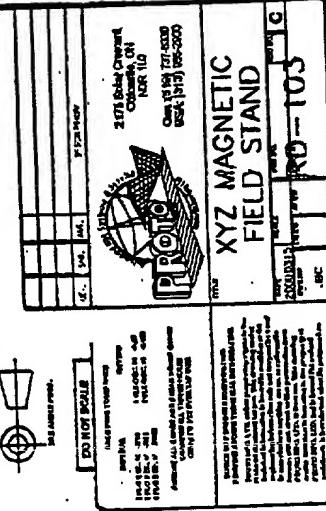
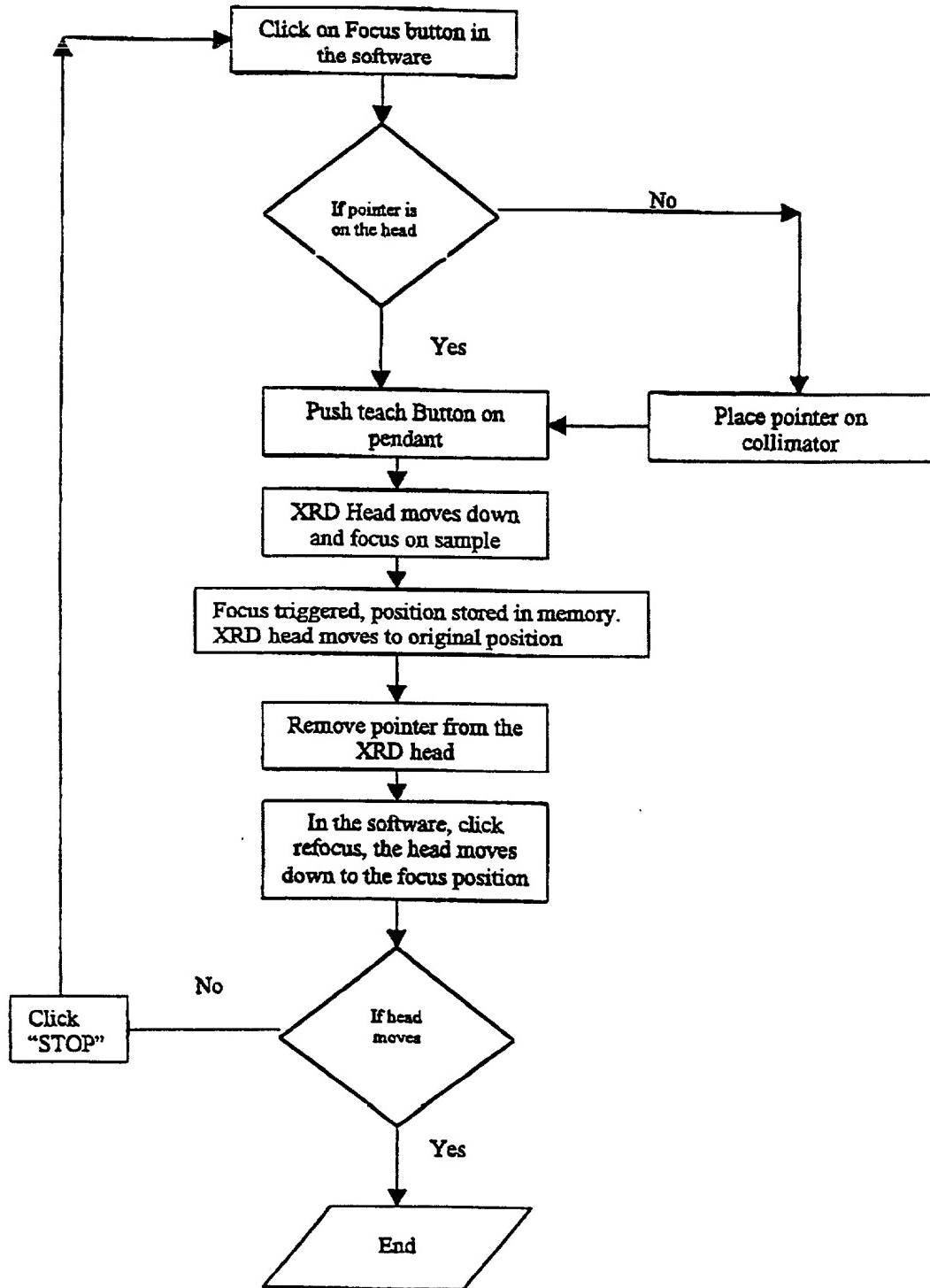


FIG.10

C/10

**"AUTOFOCUS" flowchart in Proto XRDWin software**

F16.11A

7/10

## "TEACH- MAP" Flow -Chart

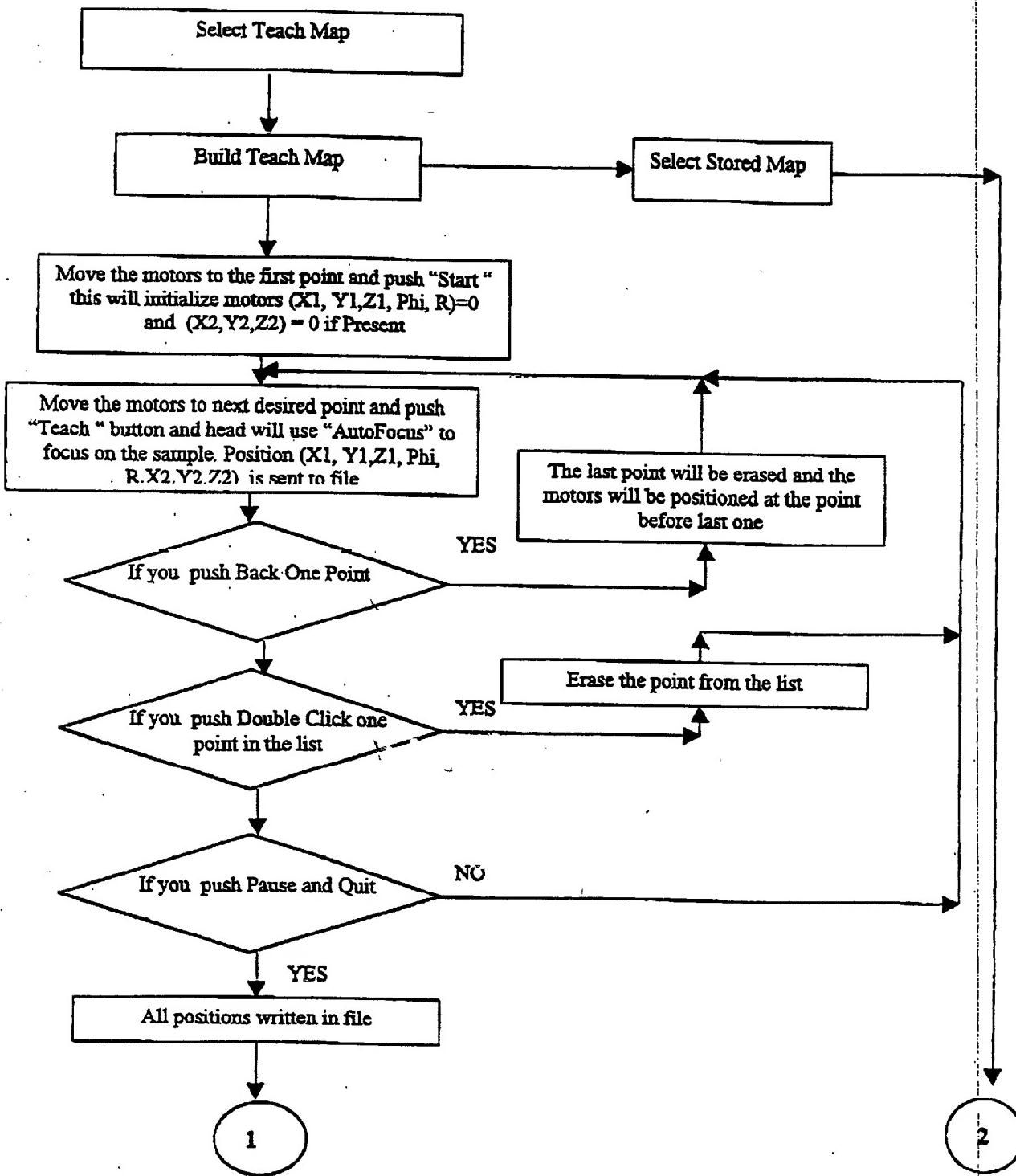
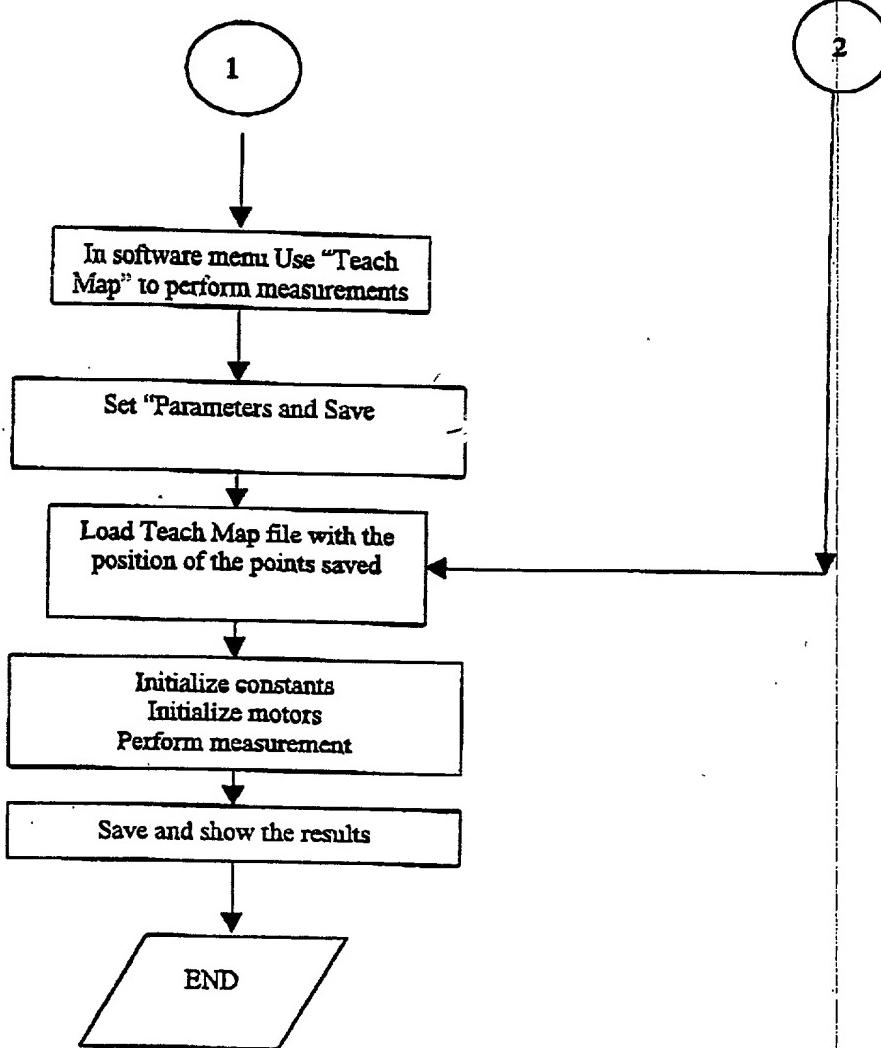
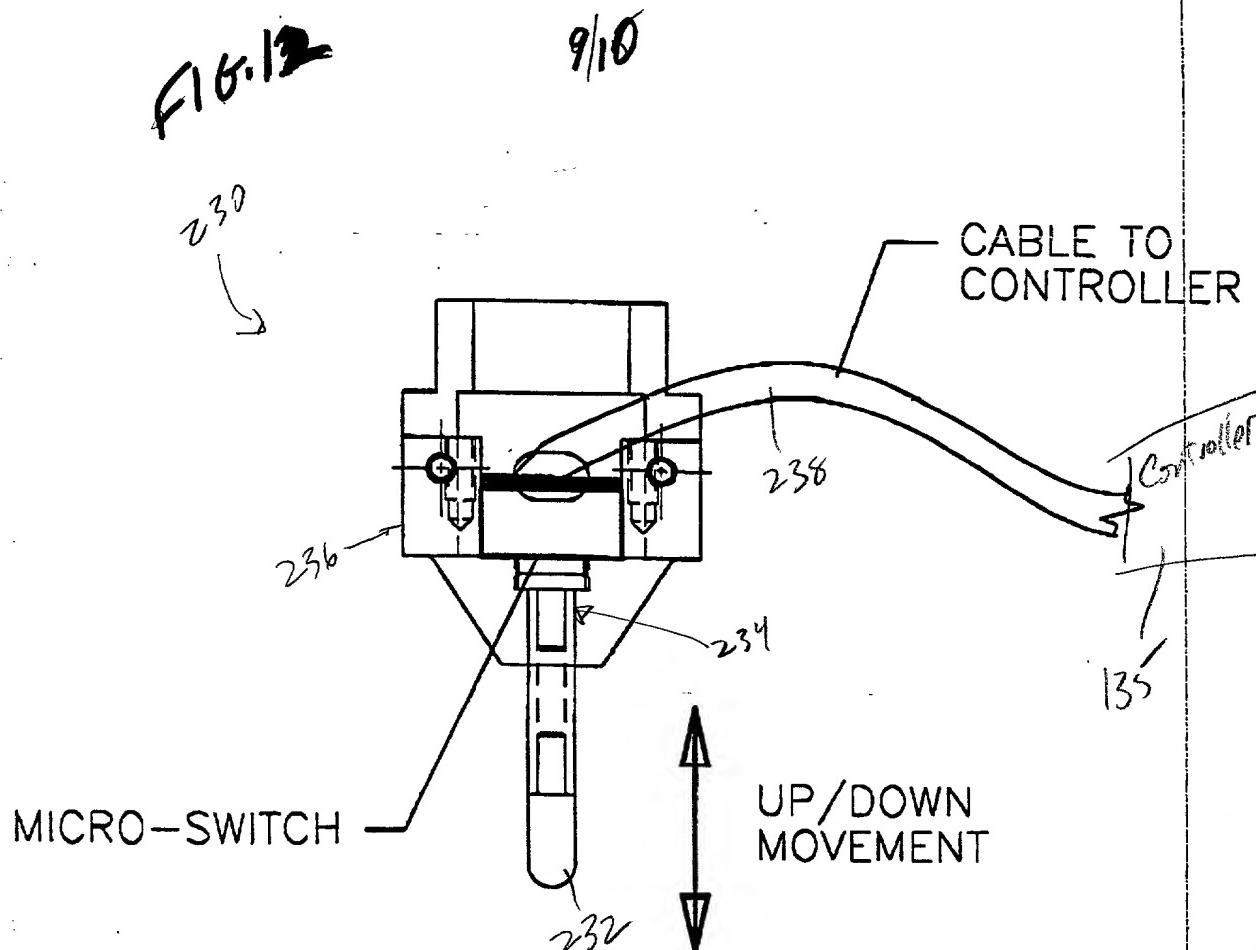


FIG.11B

8/10





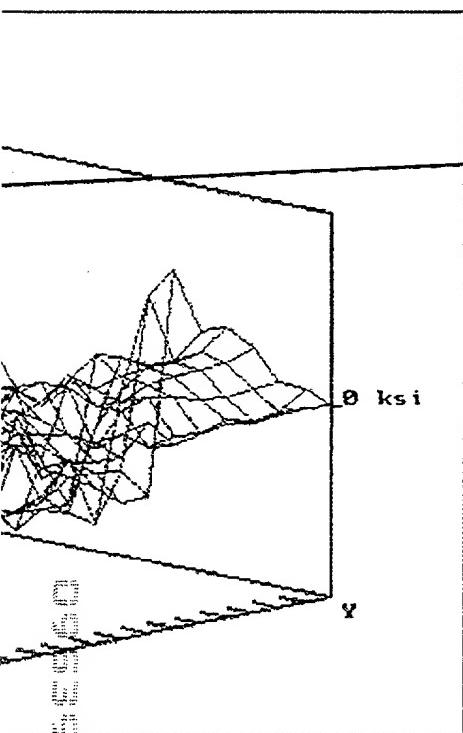
DO NOT SCALE		
MACHINING TOLERANCE		
IMPERIAL	METRIC	
2 PLCDG. +/- .010	1 PLCDG. +/- .028	
3 PLCDG. +/- .001	2 PLCDG. +/- .028	
4 PLCDG. +/- .0005		
REMOVE ALL BURRS AND BREAK SHARP CORNERS CHAMFER ALL TAPPED HOLES 45deg TO 1/8 OVER TAP SIZE		
<small>NOTICE TO PERSONS RECEIVING THIS DRAWING AND/OR TECHNICAL INFORMATION: PROTO MFG. LTD. holds proprietary rights to the material contained herein. This drawing and/or technical information is issued in confidence for manufacturing purposes only and may not be used for any other purpose without permission from PROTO MFG. LTD. in writing. This drawing and/or technical information is the property of PROTO MFG. LTD. and is loaned for review; assistance to be rendered when its purpose has been served.</small>		
2175 Solar Crescent Oldcastle, ON N0R 1L0		
Can.: (519) 787-6330 USA: (313) 985-2900		
TITLE: FOCUS POINTER		
DATE: 20000327	SCALE: 1:100	JOB NO.:
DRAWER:	CRD	UPD:
PART NO.:		
JBC RD-103		
SHEET NO. OF		

# UNLEASH the Power of Automated Stress Mapping<sup>©</sup>

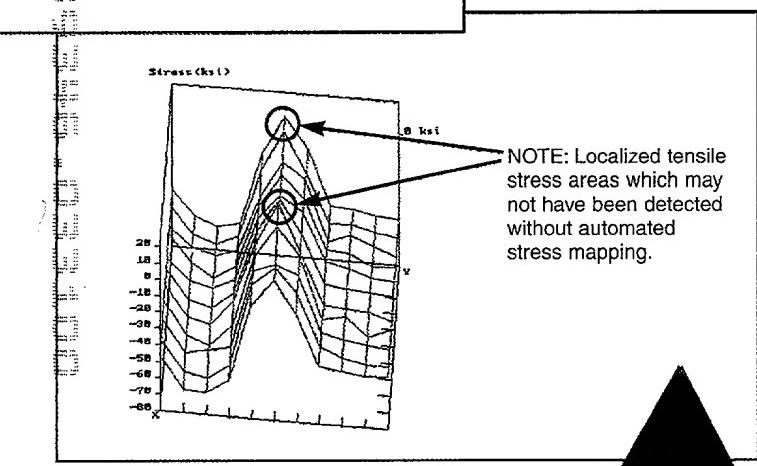
10/10

## RESIDUAL STRESS TRACKING<sup>©</sup> (RST<sup>®</sup>)

Characterizing Residual Stress on the same component after different processes to solve premature fatigue failure.



NOTE: Localized area of high tensile stresses in heat affected zone presents greater potential risk of crack initiation. This area may not have been detected without the application of automated stress mapping.

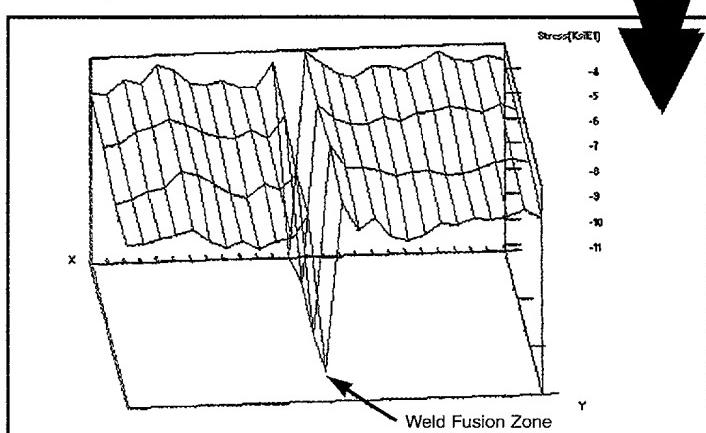


NOTE: Localized tensile stress areas which may not have been detected without automated stress mapping.

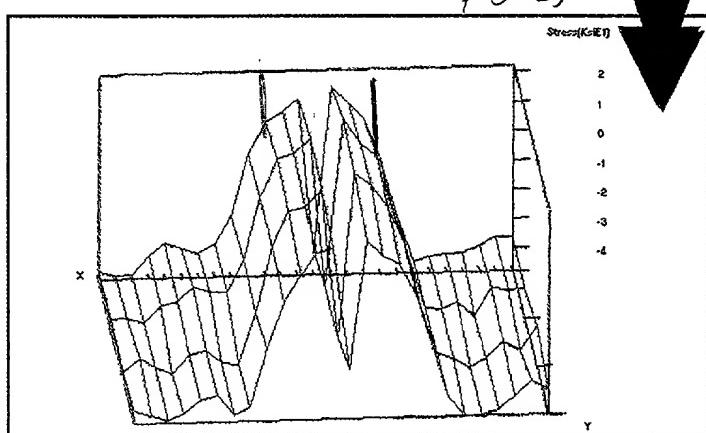
### Laser Welded Stainless Steel Pipe

The residual stress in a 316 stainless steel pipe that was laser welded was mapped through the weld and parent material. The concern was that the laser weld has created tensile residual stress levels near yield which could decrease the burst strength of the pipe while in service.

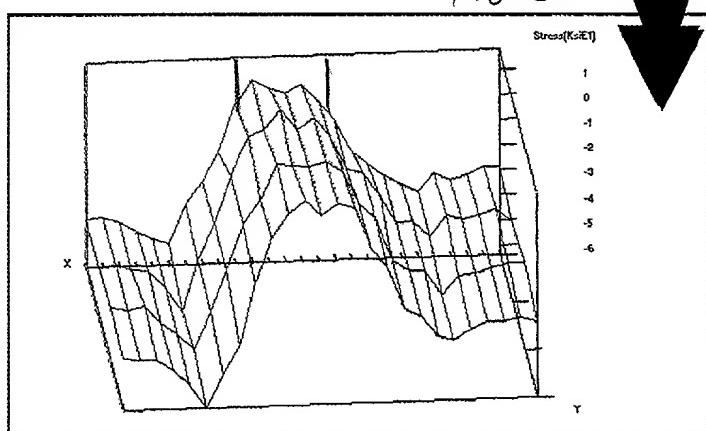
The residual stress map above reveals localized tensile residual stress areas in the center of the laser weld. If this section of pipe were placed in service, the tensile residual stress maxima already existing in the center of the weld would be increased even more due to the applied stress of the working pressure on the pipe, thus making this area highly susceptible to SCC. Some post weld residual stress management process would be recommended to introduce compressive surface stresses in the weld and HAZ.



The residual stress map after resistance welding.



The same weld after "heat treatment". NOTE: Introduction of tensile residual stresses sufficient to reduce fatigue life.



The same weld after hand grinding further introducing counter productive tensile stresses.

**DECLARATION  
FOR UTILITY OR DESIGN  
PATENT APPLICATION**

XXDeclaration     Declaration  
Submitted              Submitted  
With                   After  
Initial                Initial  
Filing                Filing

) Attorney Docket No.: 68671  
) First Named Inventor: Michael Brauss  
) \_\_\_\_\_  
) Application Number:  
)  
) Filing Date: Herewith  
) Group Art Unit:  
) Examiner Name:

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled:

X-RAY DIFFRACTION APPARATUS AND METHOD

(Title of Invention)

the specification of which:

- (x) is attached hereto, or.  
( ) was filed by an authorized person on my behalf on \_\_\_\_\_ (Date)  
as United States Application Number \_\_\_\_\_  
or PCT International Application Number \_\_\_\_\_,  
and was amended on \_\_\_\_\_ (if applicable).  
(Date)

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims, as amended by any amendment specifically referred to above.

I acknowledge the duty to disclose information which is material to patentability as defined in Title 37, Code of Federal Regulations, §1.56.

I hereby claim foreign priority benefits under Title 35, United States Code, §119(a)-(d) or §365(b) of any foreign application(s) for patent or inventor's certificate, or §365(a) of any PCT international application which designated at least one country other than the United States of America, listed below, and I have also identified below, by checking the box, any foreign application for patent or inventor's certificate, or any PCT international application, on this invention filed by me or my legal representatives or assigns and having a filing date before that of the application on which priority is claimed:

Prior Foreign Application Number(s)	Country	Foreign Filing Date	Priority Not Claimed	Certified Copy Attached Yes	Certified Copy Attached No
			<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
			<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
			<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
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			<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
			<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>

Additional foreign application numbers are listed on a supplemental priority data sheet attached hereto.

I hereby claim the benefit under Title 35, United States Code, §119(e) of any United States provisional application(s) listed below:

Provisional Application  
Number(s)

60/127,219

Provisional Application  
Filing Date

March 31, 1999

Additional provisional application numbers are listed on a supplemental priority data sheet attached hereto.

I hereby claim the benefit under Title 35, United States Code, §120, of any prior United States application(s), or under §365(c) of any PCT international application(s) designating the United States of America, listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States or PCT international application(s) in the manner provided by the first paragraph of Title 35, United States Code, §112, I acknowledge the duty to disclose all information known by me to be material to patentability as defined in Title 37, Code of Federal Regulations, §1.56, which became available between the filing date of the prior application(s) and the national or PCT international filing date of this application:

Prior U.S. Application Number	Prior PCT International Application Number	Filing Date of U.S. or PCT International Application	Patent Number (if applicable)
-------------------------------	--	--	-------------------------------

Additional U.S. or PCT international application numbers are listed on a supplemental priority data sheet attached hereto.

As a named inventor, I hereby appoint the practitioners associated with Customer Number 22242, with full power of substitution and revocation, to prosecute this application and to transact all business in the United States Patent and Trademark Office connected therewith, and request that all correspondence and telephone calls in respect to this application be directed to FITCH, EVEN, TABIN & FLANNERY, Suite 1600, 120 South LaSalle

Street, Chicago, Illinois 60603-3406, Telephone No. (312) 577-7000,  
Facsimile No. (312) 577-7007, CUSTOMER NUMBER 22242.



I hereby declare that all statements made herein of my own knowledge are true, and that all statements made herein on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code, and that such willful false statements may jeopardize the validity or enforceability of the application or any patent issued thereon.

Full name of sole or one  
joint inventor:

Michael Brauss

(Given names first, with Family name last)

Inventor's signature:

Date:

Residence:

(City and State for U.S. Residents;  
City and Country for others)

Post Office Address:

Citizenship:

Full name of sole or one  
joint inventor:

(Given names first, with Family name last)

Inventor's signature:

Date:

Residence:

(City and State for U.S. Residents;  
City and Country for others)

Post Office Address:

Citizenship: